ON Semiconductor

Is Now

Onsemi

To learn more about onsemi[™], please visit our website at <u>www.onsemi.com</u>

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product factures, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and asfety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or by customer's technical experts. onsemi products and actal performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application, Buyer shall indemnify and hold onsemi and its officers, employees, subsidiari

MOSFET – Power, Single, N-Channel, DPAK/IPAK 25 V, 65 A

Features

- Trench Technology
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- VCORE Applications
- DC-DC Converters
- High/Low Side Switching

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Para	Parameter				Unit
Drain-to-Source Vo	Drain-to-Source Voltage			25	V
Gate-to-Source Vol	tage		V _{GS}	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	۱ _D	13	А
Current R _{θJA} (Note 1)		$T_A = 85^{\circ}C$		10	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	PD	2.0	W
Continuous Drain Current R _{θ.IA}	1	T _A = 25°C	ID	10.4	А
(Note 2)	Steady State	$T_A = 85^{\circ}C$		8.0	
Power Dissipation $R_{\theta JA}$ (Note 2)	Sidle	T _A = 25°C	PD	1.28	W
Continuous Drain Current $R_{\theta JC}$		T _C = 25°C	Ι _D	65	А
(Note 1)		T _C = 85°C	1	50	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	PD	50	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	130	A
Current Limited by P	ackage	$T_A = 25^{\circ}C$	I _{DmaxPkg}	45	А
Operating Junction a Temperature	and Storage	!	T _J , T _{STG}	–55 to +175	°C
Source Current (Bod	ly Diode)		۱ _S	42	А
Drain to Source dV/c	Drain to Source dV/dt			6	V/ns
$ \begin{array}{l} \mbox{Single Pulse Drain-to-Source Avalanche} \\ \mbox{Energy } (T_J = 25^\circ C, V_{DD} = 50 \mbox{ V}, V_{GS} = 10 \mbox{ V}, \\ \mbox{I}_L = 13 \mbox{ A}_{pk}, L = 1.0 \mbox{ mH}, R_G = 25 \ \Omega) \end{array} $			EAS	84.5	mJ
Lead Temperature for (1/8" from case for 1		Purposes	ΤL	260	°C

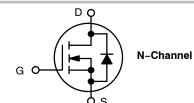
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

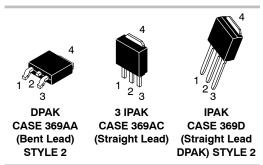


ON Semiconductor®

http://onsemi.com

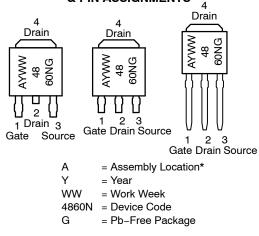
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
25 V	7.5 m Ω @ 10 V	65 A	
20 0	11.1 m Ω @ 4.5 V	05 A	







& PIN ASSIGNMENTS



* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	3	
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	75	°C/VV
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	117	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_{D} = 250 μ A		25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				21		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	
		V _{DS} = 20 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.45		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		6.1	7.5	mΩ
		V _{GS} = 4.5 V	I _D = 30 A		8.9	11.1	
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			48		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				1308		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 N	IHz, V _{DS} = 12 V		342		pF
Reverse Transfer Capacitance	C _{RSS}				169		
Total Gate Charge	Q _{G(TOT)}				11	16.5	
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 30 A			1.2		
Gate-to-Source Charge	Q _{GS}				3.9		nC
Gate-to-Drain Charge	Q _{GD}				4.7		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 30 A			21.8		nC

	4)			
Turn-On Delay Time	t _{d(ON)}		12.2	
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,	20.1	
Turn-Off Delay Time	t _{d(OFF)}	I_D = 15 A, R_G = 3.0 Ω	15.2	
Fall Time	t _f]	4.3	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ns

3. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%.

4. Switching characteristics are independent of operating junction temperatures.

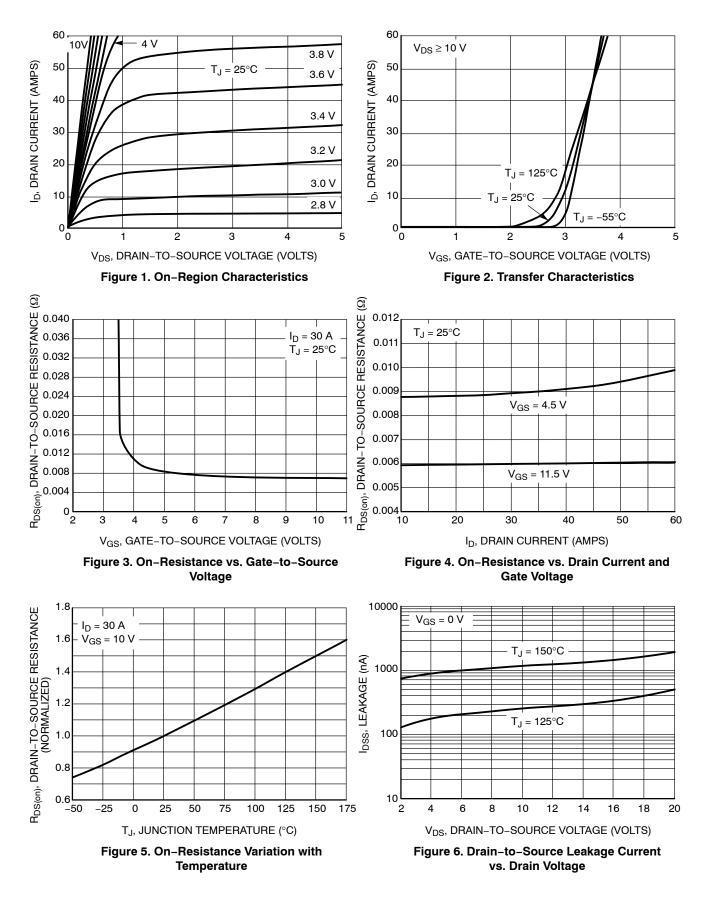
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (M	Note 4)						
Turn-On Delay Time	t _{d(ON)}				7.1		
Rise Time	t _r	V _{GS} = 11.5 V, V	_{DS} = 15 V,		17		ns
Turn-Off Delay Time	t _{d(OFF)}	V _{GS} = 11.5 V, V I _D = 15 A, R _G	= 3.0 Ω		22		
Fall Time	t _f				2.3		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.9	1.2	
	$V_{SD} \qquad V_{GS} = 0 V, \qquad I_{J} = 25^{\circ}C$ $I_{S} = 30 A \qquad T_{J} = 125^{\circ}C$		0.76		V		
Reverse Recovery Time	t _{RR}	•			12.7		
Charge Time	t _a	V _{GS} = 0 V, dIS/dt	= 100 A/μs,		7.0		ns
Discharge Time	t _b	V_{GS} = 0 V, dIS/dt = 100 A/µs, I_S = 30 A			5.7		
Reverse Recovery Charge	Q _{RR}				3.5		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	T _A = 25°C			2.49		
Drain Inductance, DPAK	L _D				0.0164		-
Drain Inductance, IPAK	L _D				1.88		nH
Gate Inductance	L _G				3.46		
Gate Resistance	R _G	1			0.75		Ω

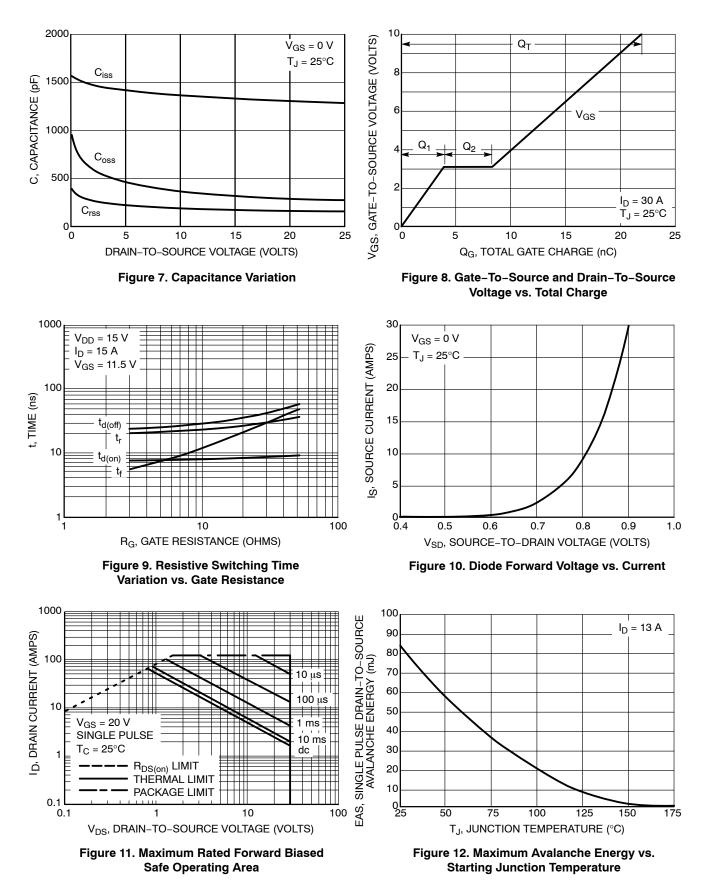
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES

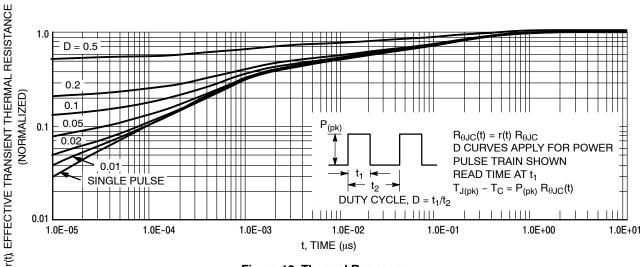


Figure 13. Thermal Response

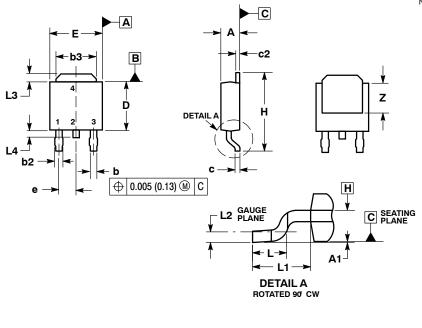
ORDERING INFORMATION

Device	Package	Shipping [†]
NTD4860NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4860N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD4860N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units / Rail

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE) CASE 369AA **ISSUE B**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

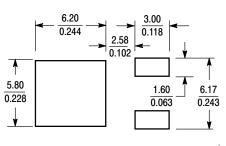
 - PLANE H.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

SOLDERING FOOTPRINT*

PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

STYLE 2:



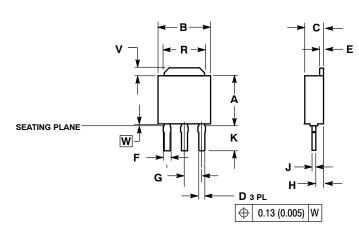
 $\left(\frac{mm}{inches}\right)$ SCALE 3:1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

3 IPAK, STRAIGHT LEAD CASE 369AC

ISSUE O



SEATING PLANE IS ON TOP OF DAMBAR POSITION. DIMENSION A DOES NOT INCLUDE DAMBAR POSITION OR MOLD GATE. 4 INCHES MILLIMETERS DIM MIN MAX MIN MAX 0.245 5.97 А 0.235 6.22 **B** 0.250 0.265 6.35 6.73 **C** 0.086 0.094 2.19 2.38 D 0.027 0.035 0.69 0.88 Е 0.018 0.023 0.46 0.58 F 0.037 0.043 0.94 1.09 G 0.090 BSC 2.29 BSC H 0.034 0.040 0.87 1.01 J 0.018 0.023 0.46 0.58

3.40

4.57

0.89

3.60

5.46

1.27

0.25

0.134 0.142

W 0.000 0.010 0.000

R0.1800.215V0.0350.050

1.. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

NOTES:

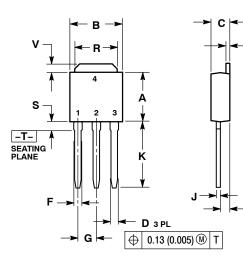
2

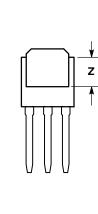
З.

IPAK CASE 369D ISSUE C

Ε

·H





NOTES 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

к

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
v	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN З. SOURCE 4. DRAIN

ON Semiconductor and the 💷 are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

NTD4860N/D